

Lecture 1: Fundamental Concept of Statistical Learning

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1 Fundamental Concepts

1.1 Definitions

- **Definition (*Data*)**

Define an **observation** as a d -dimensional vector x . The *unknown* nature of the observation is called a **class**, denoted as y . The domain of observation is called an **input space** or **feature space**, denoted as $\mathcal{X} \subset \mathbb{R}^d$, whereas the domain of class is called the **target space**, denoted as \mathcal{Y} . For **classification task**, $\mathcal{Y} = \{1, \dots, M\}$; and for **regression task**, $\mathcal{Y} = \mathbb{R}$. Denote a collection of n **samples** as $\mathcal{D}_n := \{(x_i, y_i) : 1 \leq i \leq n\}$. \mathcal{D}_n is a finite subset in $\mathcal{X} \times \mathcal{Y}$.

- **Definition (*Concept Class as a Function Class*)**

A **concept** $c : \mathcal{X} \rightarrow \mathcal{Y}$ is the *input-output association* from the nature and is *to be learned* by a learning algorithm. Denote \mathcal{C} as *the set of all concepts* we wish to learn as the **concept class**:

$$\mathcal{C} := \{c : \mathcal{X} \rightarrow \mathcal{Y}\} = \mathcal{Y}^{\mathcal{X}}.$$

Concept class \mathcal{C} is a *function class*.

- Learning is formalized into two different scenarios:

1. In **deterministic** scenario: Assume that there exist measurable space $(\mathcal{X}, \mathcal{B})$, where $X \in \mathcal{X}$ is the **random vector** in \mathcal{X} , i.e.

$$X : (\Omega, \mathcal{F}, \mathbb{P}) \rightarrow (\mathcal{X}, \mathcal{B})$$

is \mathcal{F}/\mathcal{B} measurable. Let \mathcal{P}_X be *the induced probability distribution* on X .

Remark (*Sample in Deterministic Scenario*)

In *deterministic scenario*, denote a collection of n *independent identically distributed* (*i.i.d.*) **random samples** generated by \mathcal{P}_X as \mathcal{D}_n , i.e.

$$\mathcal{D}_n := \{X_i : 1 \leq i \leq n\}.$$

Note that \mathcal{D} is a finite subset in \mathcal{X} .

Remark (*Learning Task in Deterministic Scenario*)

Given a collection of *i.i.d. samples* \mathcal{D} generated by \mathcal{P}_X , a **learner** considers a **fixed subset of concepts** $\mathcal{H} \subset \mathcal{C}$, which is referred as a **hypothesis class**, and provides a **hypothesis** or a **classifier** or a **decision function** $g \in \mathcal{H} \subset \mathcal{Y}^{\mathcal{X}}$ based on \mathcal{D} . The task of **supervised learning** is to minimize

Definition (*Generalization Error in Deterministic Scenario*) [?]

Under a *deterministic scenario*, **generalization error** or the **risk** or simply **error** for the **classifier** $g \in \mathcal{H}$ is defined as

$$R(g) \equiv L(g) = \mathcal{P}_X \{g(X) \neq c(X)\} \equiv \mathbb{E}_{\mathcal{P}_X} [\mathbb{1} \{g(X) \neq c(X)\}] \quad (1)$$

with respect to the concept $c \in \mathcal{C}$.

2. In **stochastic** scenario: Assume *both* X and Y are random, i.e. there exists a probability space $(\mathcal{X} \times \mathcal{Y}, \mathcal{B}, \mathcal{P}_{X,Y})$ so that

$$(X, Y) : (\Omega, \mathcal{F}, \mathbb{P}) \rightarrow (\mathcal{X} \times \mathcal{Y}, \mathcal{B}, \mathcal{P}_{X,Y})$$

so that the pair (X, Y) is \mathcal{F}/\mathcal{B} measurable. Let $\mathcal{P}_{X,Y}$ be the induced **joint probability distribution** on (X, Y) .

Remark (Sample in Stochastic Scenario)

In *stochastic scenario*, denote a collection of n independent identically distributed (i.i.d.) **random sample pairs** generated by joint probability $\mathcal{P}_{X,Y}$ as \mathcal{D} , i.e.

$$\mathcal{D}_n := \{(X_i, Y_i) : 1 \leq i \leq n\}.$$

Note that \mathcal{D}_n is a finite subset in $\mathcal{X} \times \mathcal{Y}$.

Definition (Generalization Error in Stochastic Scenario) [Mohri et al., 2018]

In *stochastic scenario*, **generalization error** or the **risk** or simply **error** for the classifier $g \in \mathcal{H} \subset \mathcal{C}$ is defined as

$$R(g) \equiv L(g) = \mathcal{P}_{X,Y} \{g(X) \neq Y\} \equiv \mathbb{E}_{\mathcal{P}_{X,Y}} [\mathbb{1} \{g(X) \neq Y\}] \quad (2)$$

Remark (Learning Task in Stochastic Scenario)

Given the *sample set* S generated from a (joint) probability distribution $\mathcal{P}_{X,Y}$. Given a fixed hypothesis class \mathcal{H} , the task of learner is to find a hypothesis $g \in \mathcal{H} \subset \mathcal{C}$ so that the generalization error or the *risk* or simply the *error* is minimized.

• **Remark (Deterministic vs. Stochastic)**

The main difference between these two settings is the assumption on Y :

1. In **deterministic scenario**, $Y = c(X)$ for some **unknown but deterministic** $c \in \mathcal{C}$ and the learning task is to approximate c by some function $g \in \mathcal{H}$.
2. In **stochastic scenario**, Y is a **random variable, generated jointly with the feature** X by some unknown distribution $\mathcal{P}_{X,Y}$.

The pair (X, Y) may not follow a **function relationship**. Note for a pair $(x, y) \in \mathcal{X} \times \mathcal{Y}$ to follow function relationship, for *each given* x , there *can only be one* corresponding $y \in \mathcal{Y}$. Under the stochastic assumption, *any pair* $(x, y) \in \mathcal{X} \times \mathcal{Y}$ would appear as long as the corresponding measure $\mathcal{P}_{X,Y}(x, y) > 0$.

3. An **intermediate setting** assumes feature is a random vector $X \sim P_X$, and class $Y = g(X)$ for some **unknown random function** g .

$$g : (\Omega, \mathcal{F}, \mathbb{P}) \rightarrow (\mathcal{C}, \mathcal{C})$$

where g is \mathcal{F}/\mathcal{C} measurable, and $g(\omega) \in \mathcal{C} = \mathcal{Y}^{\mathcal{X}}$ for each $\omega \in \mathcal{C}$.

One may assume that g is generated following an independent generation process from \mathcal{P}_X . Or, one may assume that (X, g) are not independent, e.g. $g = g(\cdot | \sigma(X_1, \dots, X_n))$ is determined by a stochastic process $X_t : t \leq n$ of past events.

In [Devroye et al., 2013], the author defines the random function g as the function of stochastic process $\{(X_t, Y_t) : t \leq n\}$ of past events assuming both (X, Y) are random.

Definition (*Random Function by Independent Random Samples*) [Devroye et al., 2013]

Given a collection of samples $\mathcal{D}_n = ((X_i, Y_i), 1 \leq i \leq n)$, a (stochastic) classifier/hypothesis is defined as

$$\begin{aligned} g_n(x) &= g_n(x; \mathcal{D}_n) \\ &:= g(x | \sigma((X_i, Y_i) : 1 \leq i \leq n)). \end{aligned}$$

Thus g_n is a (random) function determined by σ -algebra $\sigma(\mathcal{D}_n) := \sigma((X_t, Y_t) : t \leq n)$, and its output is considered as a *random variable* depended upon data \mathcal{D}_n . Note that it should be distinguished with the fixed concept $c \in \mathcal{C}$ or a unknown but fixed hypothesis $g(\cdot) \in \mathcal{H}$, whereas $g_n(\cdot; \mathcal{D}_n) \in \mathcal{H}$.

A sequence of hypotheses $\{g_n\}_n$ is called a classification rule where each g_n is a function of data so is a random mapping

$$g_n : \mathcal{X} \times (\mathcal{X} \times \mathcal{Y})^n \rightarrow \mathcal{Y}.$$

- **Definition** (*Generalization Error of Estimated Hypothesis*) [Devroye et al., 2013]

Given the data \mathcal{D}_n , we can define *the conditional probability of error*:

$$L_n(g) = L(g_n) := \mathcal{P}_{X,Y} \{g_n(X; \mathcal{D}_n) \neq Y | \mathcal{D}_n\} \equiv \mathbb{E}_{X,Y} [\mathbb{1} \{g_n(X) \neq Y\} | \mathcal{D}_n] \quad (3)$$

This is a random variable because it depends upon the data \mathcal{D}_n . So, L_n averages over the distribution of (X, Y) , but *the data is held fixed*. Averaging over the data as well would be unnatural, because in a given application, one has to live with the data at hand.

- **Remark** (*Learning in Deterministic vs. Stochastic*)

1. (Function Approximation): The learning task in *deterministic scenario* is to *approximate* $c \in \mathcal{C}$ with $g \in \mathcal{H} \subset \mathcal{C}$ given samples \mathcal{D} . The *function approximator* g should be “close” to the unknown c under the unknown distribution P_X .

The theoretial analysis concerns that under *the worst case scenario*, if it is possible for a function g in function class \mathcal{H} to approximate c so that the generation error approaches to zero.

2. (Distribution Approximation): The learning task in *stochastic scenario* is to *approximate* the joint probability measure $\mathcal{P}_{X,Y}$ with $\hat{\mathcal{P}}_{X,Y}$ given samples \mathcal{D} . *The distribution estimator* $\hat{\mathcal{P}}_{X,Y}$ should “converge” to the unknown $\mathcal{P}_{X,Y}$ asymptotically.

- **Remark** : (*Statistical Decision*) [Berger, 2013]

The *statistical learning theory* is closely related to the *statistical decision theory* in which the terms such as (Empirical) Risk/Utility, decision function are used as an alternative to the terms like (Empirical) Error, hypothesis/classifier.

1.2 Bayes Error

- **Definition** (*Bayes Error in Stochastic Scenario*)

Under a given distribution $\mathcal{P}_{X,Y}$, the Bayes error L^* or Bayes risk R^* is defined as

$$R^* \equiv L^* = \inf_{g \in \mathcal{C}} \{L(g)\}, \quad (4)$$

where the infimum is with respect to *all* measurable function $g : \mathcal{X} \rightarrow \mathcal{Y}$. And the *hypothesis* g^* such that $L(g^*) = L^*$ is called the **Bayes classifier**.

- **Remark** *The Bayes Error is only a function of underlying distribution* $\mathcal{P}_{X,Y}$ and it does not depend on choice of function g or function class \mathcal{H} .

$$L^* = L^*(\mathcal{P}_{X,Y}) := \inf_g \{ \mathcal{P}_{X,Y} \{g(X) \neq Y\} \}.$$

- **Remark** (*Bayes Error in Deterministic Scenario*)

Under *the deterministic* setting, the Bayes error is $L^* = 0$ since by assumption $Y = c(X)$ for some $c \in \mathcal{C}$, thus the infimum is zero.

- **Remark** (*Bayes Classifier if $\mathcal{P}_{X,Y}$ is Known*)

The learning task is concerning about the situation when $\mathcal{P}_{X,Y}$ is *unknown* but *if $\mathcal{P}_{X,Y}$ is known*, then *the optimal hypothesis* is known as *the posterior conditional expectation*:

$$\eta(X) := \mathcal{P}[Y|X] = \frac{d\mathcal{P}_{X,Y}}{d\mathcal{P}_X}$$

Note that $\mathcal{P}[Y|X]_\omega$ is a function of X given each $\omega \in \Omega$, which means that $g(X, \omega) := \mathcal{P}[Y|X]_\omega$ is a random function itself. For $\mathcal{Y} = \{0, 1\}$ and X be discrete random variables, it can be written as

$$\begin{aligned} \eta(x) &= \mathcal{P} \{Y = 1 | X = x\} \\ &= \mathbb{E}_{p(y|x)} [y | X = x]. \end{aligned} \tag{5}$$

and *the Bayes classifier* (decision function)

$$\begin{aligned} g^*(x) &= \operatorname{argmax}_{y \in \{0,1\}} P(Y = y | X = x) \\ &= \begin{cases} 1 & \eta(x) > \frac{1}{2} \\ 0 & \text{o.w.} \end{cases} \end{aligned} \tag{6}$$

with the corresponding **Bayes error**

$$\begin{aligned} L^* &= \mathbb{E}_{P(X)} [\min \{P(Y = y|X) \mid y \in \{0, 1\}\}] \\ &= 1 - \mathbb{E}_{P(X)} [\eta(X) \mathbb{1} \{\eta(X) > 1/2\} + (1 - \eta(X)) \mathbb{1} \{\eta(X) \leq 1/2\}] \end{aligned} \tag{7}$$

- We summarize our discussion as follows

Proposition 1.1 (*Conditional Estimator is Bayes Classifier if Distribution is Known*)

[Devroye et al., 2013]

Given the posterior (conditional) probability $\eta(x) = \mathcal{P}(Y = 1|X = x) = \mathbb{E}_{p(y|x)} [Y|X = x]$, where $\mathcal{P}(X, Y)$ is the underlying distribution of data and the Bayes decision function

$$\begin{aligned} g^*(x) &= \mathbb{1} \{\mathcal{P}(Y = 1|X = x) > 1/2\} \\ &= \mathbb{1} \{\mathbb{E}_{p(y|x)} [y | X = x] > 1/2\}, \end{aligned}$$

for any decision function $g : \mathcal{X} \rightarrow \{0, 1\}$,

$$\mathcal{P} \{g^*(X) \neq Y\} \leq \mathcal{P} \{g(X) \neq Y\}$$

Proof: Given $X = x$, the conditional error probability of any g can be expressed as

$$\begin{aligned}
& \mathcal{P}\{g(X) \neq Y|X = x\} \\
&= 1 - \mathcal{P}\{Y = g(X)|X = x\} \\
&= 1 - (\mathcal{P}\{Y = 1, g(X) = 1|X = x\} + \mathcal{P}\{Y = 0, g(X) = 0|X = x\}) \\
&= 1 - (\mathbb{1}\{g(x) = 1\} \mathcal{P}\{Y = 1|X = x\} + \mathbb{1}\{g(x) = 0\} \mathcal{P}\{Y = 0|X = x\}) \\
&= 1 - [\mathbb{1}\{g(x) = 1\} \eta(x) + \mathbb{1}\{g(x) = 0\} (1 - \eta(x))]
\end{aligned} \tag{8}$$

For any $x \in \mathcal{X}$,

$$\begin{aligned}
& \mathcal{P}\{g(X) \neq Y|X = x\} - \mathcal{P}\{g^*(X) \neq Y|X = x\} \\
&= \eta(x) (\mathbb{1}\{g^*(x) = 1\} - \mathbb{1}\{g(x) = 1\}) + (1 - \eta(x)) (\mathbb{1}\{g^*(x) = 0\} - \mathbb{1}\{g(x) = 0\}) \\
&= (2\eta(x) - 1) (\mathbb{1}\{g^*(x) = 1\} - \mathbb{1}\{g(x) = 1\}) \\
&\geq 0,
\end{aligned}$$

since $g^*(x) = 1$ if and only if $(2\eta(x) - 1) > 0$ and $(\mathbb{1}\{g^*(x) = 1\} - \mathbb{1}\{g(x) = 1\}) \geq 0$ if and only if $g^*(x) = 1$. \blacksquare

- **Proposition 1.2 (Plug-In Estimator)** [Devroye et al., 2013]
Consider a plug-in decision function

$$g(x) = \mathbb{1}\{\tilde{\eta}(x) > 1/2\},$$

where $\tilde{\eta}(x)$ is an estimate of $\eta(x) = \mathcal{P}(Y = 1|X = x)$, then for the error probability of plug-in decision function $g(x)$, we have

$$\mathcal{P}\{g(X) \neq Y\} - L^* = 2 \int_{\mathcal{X}} |\eta(x) - 1/2| \mathbb{1}\{g(x) \neq g^*(x)\} \mu(dx) \tag{9}$$

and

$$\begin{aligned}
\mathcal{P}\{g(X) \neq Y\} - L^* &\leq 2 \int_{\mathcal{X}} |\eta(x) - \tilde{\eta}(x)| \mu(dx) \\
&= 2\mathbb{E}_{p(X)} [\eta(X) - \tilde{\eta}(X)]
\end{aligned} \tag{10}$$

Proof: If for some $x \in \mathcal{X}$, $g(x) = g^*(x)$, then clearly the difference btw the conditional error probability of g and g^* is zero; i.e.

$$\mathcal{P}\{g(X) \neq Y|X = x\} - \mathcal{P}\{g^*(X) \neq Y|X = x\} = 0.$$

Otherwise, $g(x) \neq g^*(x)$, then

$$\begin{aligned}
& \mathcal{P}\{g(X) \neq Y|X = x\} - \mathcal{P}\{g^*(X) \neq Y|X = x\} \\
&= (2\eta(x) - 1) (\mathbb{1}\{g^*(x) = 1\} - \mathbb{1}\{g(x) = 1\}) \\
&= |2\eta(x) - 1| \mathbb{1}\{g(x) \neq g^*(x)\}
\end{aligned}$$

Thus

$$\begin{aligned}
\mathcal{P}\{g(X) \neq Y\} - L^* &= 2 \int_{\mathcal{X}} |\eta(x) - 1/2| \mathbb{1}\{g(x) \neq g^*(x)\} \mu(dx) \\
&\leq 2 \int_{\mathcal{X}} |\eta(x) - \tilde{\eta}(x)| \mu(dx),
\end{aligned}$$

since $g(x) \neq g^*(x)$ implies $|\eta(x) - \tilde{\eta}(x)| \geq |\eta(x) - 1/2|$. \blacksquare

- **Corollary 1.3** Consider a plug-in decision function

$$g(x) = \mathbb{1} \{ \tilde{\eta}_1(x) > \tilde{\eta}_0(x) \},$$

where $\tilde{\eta}_1(x)$ is an estimate of $\eta(x)$ and $\tilde{\eta}_0(x)$ is an estimate of $1 - \eta(x)$, then for the error probability of plug-in decision function $g(x)$, we have

$$\mathcal{P} \{g(X) \neq Y\} - L^* \leq \int_{\mathcal{X}} |(1 - \eta(x)) - \tilde{\eta}_0(x)| \mu(dx) + \int_{\mathcal{X}} |\eta(x) - \tilde{\eta}_1(x)| \mu(dx) \quad (11)$$

In particular, if $\tilde{\eta}_1(x) \equiv \tilde{q}_1 \tilde{p}_1(x)$ and $\tilde{\eta}_0(x) \equiv \tilde{q}_0 \tilde{p}_0(x)$, where \tilde{q}_1, \tilde{q}_0 are estimate of prior distribution for $\mathcal{P} \{Y = 1\} = q$ and $\mathcal{P} \{Y = 0\} = 1 - q$ and $\tilde{p}_1(x), \tilde{p}_0(x)$ are estimate of class conditional distribution of x given $Y = 1$ and $Y = 0$ respectively, then

$$\mathcal{P} \{g(X) \neq Y\} - L^* \leq \int_{\mathcal{X}} |(1 - q)p_0(x) - \tilde{q}_0 \tilde{p}_0(x)| dx + \int_{\mathcal{X}} |qp_1(x) - \tilde{q}_1 \tilde{p}_1(x)| dx$$

- **Definition (Generative vs. Discriminative Model)**

In stochastic scenario, following the proposition above, we have two *learning strategies*:

- A **generative model** is an estimate $\hat{\mathcal{P}}_{X,Y}$ of joint distribution $\mathcal{P}_{X,Y}$. For high dimensional data, an *efficient* estimator is hard to find.
- A **deterministic model** $g : \mathcal{X} \rightarrow \mathcal{Y}$ is a function (hypothesis) in \mathcal{H} from input to output. The task of learner is to find $g \in \mathcal{H}$ so that the generalization error is minimized;

In *probabilistic graphical models* and *Bayesian learning*, e.g. [Koller and Friedman, 2009, Murphy, 2012], a deterministic model is interpreted as an **estimate** $\hat{\mathcal{P}}(Y|X = x)$ of $\mathcal{P}(Y|X = x)$, the conditional distribution of Y given the observations $X = x$, so that

$$\begin{aligned} g(x) &= \mathbb{1} \left\{ \hat{\mathcal{P}}(Y = 1|X = x) > 1/2 \right\} \\ &= \mathbb{1} \left\{ \mathbb{E}_{\hat{\mathcal{P}}(y|x)} [y|X = x] > 1/2 \right\} \end{aligned}$$

is close to the Bayes classifier

$$\begin{aligned} g^*(x) &= \mathbb{1} \{ \eta(x) > 1/2 \} \\ &= \mathbb{1} \{ \mathbb{E}_{\mathcal{P}(y|x)} [y|X = x] > 1/2 \} \end{aligned}$$

$\mathcal{P}(Y|X = x)$ is easier to estimate than $\mathcal{P}_{X,Y}$ since Y is of lower dimensionality.

- **Exercise 1.4 (Transformation Increases Bayes Error)** [Devroye et al., 2013]
Let $T : \mathcal{X} \rightarrow \mathcal{X}'$ be an arbitrary measurable function. If $L_{\mathcal{X}}^*$ and $L_{T(\mathcal{X})}^*$ denote the Bayes error probability for (X, Y) and $(T(X), Y)$, respectively, then prove that

$$L_{T(\mathcal{X})}^* \geq L_{\mathcal{X}}^*.$$

This shows that transformation destroys information, because the Bayes risk increases.

Proof: We see that for any measurable set $B \subset \mathcal{X}'$, $\mathcal{P}(T(X) \in B) = \mathcal{P} \{X \in T^{-1}(B)\}$. Define the posterior distribution

$$\begin{aligned} \eta_T(t) &\equiv \mathcal{P} \{Y = 1|T(x) = t\} \\ \eta_T(T(x)) &= \mathbb{E} [\eta(X)|T(x)]. \end{aligned}$$

Use the F -error theorem by observing that $L^* = d_F(X, Y)$ with $F(x) = \min\{x, 1 - x\}$, thus

$$\begin{aligned}
L_{T(\mathcal{X})}^* &= d_F(T(X), Y) \\
&= \int \min\{1 - \eta_T(T(x)), \eta_T(T(x))\} p(x) \mu(dx) \\
&= \int \min\{1 - \mathbb{E}[\eta(X)|T(x)], \mathbb{E}[\eta(X)|T(x)]\} p(x) \mu(dx) \\
&\geq \int \mathbb{E}[\min\{1 - \eta(X), \eta(X)\} | T(x)] p(x) \mu(dx) \\
&= \int \min\{1 - \eta(x), \eta(x)\} p(x) \mu(dx) \\
&= d_F(X, Y) = L_{\mathcal{X}}^*. \quad \blacksquare
\end{aligned}$$

Note that for any measurable $T : (\mathcal{X}, \mathcal{B}) \rightarrow (\mathcal{X}', \mathcal{B}')$, let $X' = T(X)$ for $X : \Omega \rightarrow \mathcal{X}$,

$$\begin{aligned}
\mathbb{E}[Y|T(X)] &= \mathbb{E}[Y|T^{-1}(\sigma(X'))] \\
&= \mathbb{E}[Y|\sigma(X)|_{T^{-1}(\sigma(X'))}] \\
&\equiv \mathbb{E}[\mathbb{E}[Y|\sigma(X)] | T(X)] \\
\text{for } E \in T^{-1}(\sigma(X')) &= \sigma(T^{-1}X') \subset \sigma(X) \subset \sigma(X, Y) \\
\int_E \mathbb{E}[\mathbb{E}[Y|\sigma(X)] | \sigma(T^{-1}X')] dP_{X,Y} &= \int_E \mathbb{E}[Y|\sigma(X)] dP_{X,Y} \\
&= \int_E Y dP_{X,Y} \\
&= \int_E \mathbb{E}[Y|T(X)] dP_{X,Y} \quad \blacksquare
\end{aligned}$$

- **Exercise 1.5** [Devroye et al., 2013]
Let X' be independent with (X, Y) . Show that

$$L_{X', X}^* = L_X^*.$$

Proof: Just need to see that $\eta'(x', x) = \mathcal{P}(Y|(X', X) = (x', x)) = \mathcal{P}(Y|X = x) = \eta(x)$ by independence, the result then follows directly. \blacksquare

1.3 Consistency

- **Remark** Without explicit statement, we assume stochastic scenario, and the estimated hypothesis is written as

$$g_n(x) = g(x|\sigma((X_i, Y_i), i \leq n)) = g(x; \mathcal{D}_n)$$

where $\mathcal{D}_n = ((X_i, Y_i), 1 \leq i \leq n)$, $\sigma((X_i, Y_i), i \leq n) = \sigma(\mathcal{D}_n)$. For each x , $g_n(x)$ is a random variable itself since it depends on \mathcal{D}_n , which is a collection of random variables.

- **Definition** (*Consistent Classification Rules*)

A classification rule $\{g_n\}$ is **consistent (asymptotically Bayes-risk efficient)** for a certain distribution $\mathcal{P}_{X,Y}$ if

$$L_n(g) := L(g_n) = \mathcal{P}_{X,Y} \{g_n(X) \neq Y | \mathcal{D}_n\} \xrightarrow{\mathcal{P}} L^*, \text{ as } n \rightarrow \infty$$

Since $1 \geq L_n \geq L^*$, the above is equivalent to **convergence in probability**

$$\lim_{n \rightarrow \infty} \mathcal{P} \{L_n - L^* \geq \epsilon\} = 0.$$

Also the classification rule is the **strongly consistent** if

$$L_n := L(g_n) \rightarrow L^* \text{ a.s.}$$

- **Remark** Given (X_i, Y_i) are i.i.d., $\mathcal{P}(\mathcal{D}_n) = \mathcal{P}_{X,Y}^n$. And $\mathcal{P}\{L_n \leq \epsilon\} := \mathcal{P}_{X,Y}^n\{L_n \leq \epsilon\}$.
- **Remark** A **consistent rule** $\{g_n\}$ guarantees us that taking more samples essentially suffices to **roughly reconstruct** the unknown distribution of (X, Y) because L_n can be pushed as close as desired to L^* . In other words, *infinite amounts of information can be gleaned from finite samples*. Without this guarantee, we would not be motivated to take more samples.

We should be careful and **not impose conditions on** (X, Y) for the consistency of a rule, because such conditions may not be verifiable.

- A stronger version of consistency even if the underlying distribution \mathcal{P} is unknown

Definition (*Universal Consistency*)

A sequence of *classification rules* is called **universally consistent (strongly) consistent** if it is **(strongly) consistent** for **any distribution** $\mathcal{P}(X, Y)$, i.e.

$$\lim_{n \rightarrow \infty} \mathcal{P} \{L_n - L^* \geq \epsilon\} = 0, \quad \forall \mathcal{P}$$

and

$$\mathcal{P} \left\{ \limsup_{n \rightarrow \infty} \{L_n - L^* \geq \epsilon\} \right\} = 0, \quad \forall \mathcal{P}.$$

- Recall **the plug-in rule** of an estimated posterior conditional probability $\eta_n(x)$

$$g_n(x) = \begin{cases} 0 & \eta_n(x) \leq \frac{1}{2} \\ 1 & \text{o.w.} \end{cases}$$

Following Proposition 1.2, we have the following consistency results:

Remark (**Error Estimate of Plug-In Rule, L^1 norm**) [Devroye et al., 2013]

The **error probability** of the classifier $g_n(x)$ defined above satisfies the inequality

$$L(g_n) - L^* \leq 2 \int |\eta(x) - \eta_n(x)| \mu(dx) = 2\mathbb{E} [|\eta(X) - \eta_n(X)| | \mathcal{D}_n]$$

where $\eta(x) = \mathcal{P}[Y = 1 | X = x]$ is the Bayes classifier.

By Cauchy-Schwartz inequality, we have

Corollary 1.6 (*Error Estimate of Plug-In Rule, L^2 norm*) [Devroye et al., 2013]
If

$$g_n(x) = \begin{cases} 0 & \eta_n(x) \leq \frac{1}{2} \\ 1 & o.w. \end{cases}$$

then its **error probability** satisfies

$$\begin{aligned} L(g_n) - L^* &:= \mathcal{P}_{X,Y} \{g_n(X) \neq Y | \mathcal{D}_n\} - L^* \leq 2 \sqrt{\int |\eta(x) - \eta_n(x)|^2 \mu(dx)} \\ &= 2 \sqrt{\mathbb{E} [|\eta(X) - \eta_n(X)|^2 | \mathcal{D}_n]} \end{aligned} \quad (12)$$

Thus if we can show that under any distribution $\mathcal{P}_{X,Y}$, $\eta_n \rightarrow \eta$, i.e.

$$\mathbb{E} [|\eta(X) - \eta_n(X)|^2 | \mathcal{D}_n] \rightarrow 0, \quad \text{as } n \rightarrow \infty,$$

we will have **strong universal consistency**.

- **Remark (Weak Convergence for Functions)**

Recall for a function η_n converges to η weakly, $\eta_n \xrightarrow{w} \eta$ if and only if

$$I(\eta_n) \rightarrow I(\eta), \quad \forall I \in \mathcal{H}^*$$

Note that for continuous function $\eta_n \in \mathcal{C}_c(\mathcal{X})$ with compact support on a locally compact Hausdorff space \mathcal{X} , the dual space is the space of regular Borel measures on X . In other words, $\eta_n \xrightarrow{w} \eta$ if and only if

$$\int \eta_n d\mathcal{P} \rightarrow \int \eta d\mathcal{P}, \quad \forall \mathcal{P} \in \mathcal{P}(\mathcal{X}),$$

which corresponds to **the strong consistency definition**.

1.4 No Free Lunch

- **Remark** There are some significant results known to the learning community

- **For every fixed n there exists a distribution where the classifier is arbitrarily bad.**

For any $\epsilon > 0$ and any integer n and classification rule g_n , there exists a distribution of (X, Y) with Bayes risk $L^* = 0$ such that

$$\mathbb{E} [L(g_n(\cdot | \mathcal{D}_n))] \geq \frac{1}{2}.$$

- **Universal rate of convergence guarantees do not exist.** That is, for any rule,

$$\liminf_{n \rightarrow \infty} \sup_{\forall \mathcal{P}_{X,Y}: L^* + \epsilon < 1/2} \mathcal{P} \{L_n \geq L + \epsilon\} > 0$$

Rate of convergence studies must involve certain subclasses of distributions of (X, Y) .

Moreover, *there exists no universally consistent learning algorithm* such that $L(g_n)$ converges **uniformly over all distributions** to L^* .

- ***There exists no universally superior learning algorithm.*** For every sequence of classification rules f_n , there is a *universally consistent sequence of classification rules* g_n such that for *some distribution* on $\mathcal{X} \times \mathcal{Y}$

$$L(f_n) > L(g_n), \quad \forall n > 0$$

- **Remark** In summary, there are two issues:

1. ***No Restriction on Function Class \mathcal{H}*** , i.e. *convergence to Bayes risk L^** , i.e. the infimum generalization error for *all possible functions*.
2. ***No Restriction on Underlying Distribution $\mathcal{P}_{X,Y}$*** , i.e. be *universally consistent for all possible distribution $\mathcal{P}_{X,Y}$* .

On the other hand,

1. ***Restriction of the class of distributions*** on $\mathcal{X} \times \mathcal{Y}$ can lead to *convergence rates to Bayes risk L^* for universally consistent learning algorithms*.

Problem: Assumptions cannot be tested since $\mathcal{P}_{X,Y}$ is unknown. Performance guarantees are only valid under the made assumptions.

2. ***Restriction of the function class*** may lead to *no universal consistency possible*.

Problem: Comparison to the best possible function in the class is possible *uniformly over all distributions*. But *no performance guarantees* with respect to *the Bayes risk*.

1.5 Empirical Risk Minimization

- **Definition (*Empirical Error/ Risk*)**

Given the data \mathcal{D}_n , the *training error* or the *empirical error/risk* of a hypothesis $g \in \mathcal{H}$ is defined as

$$\begin{aligned} \hat{L}_n(g) &= \frac{1}{n} \sum_{i=1}^n \mathbb{1} \{g(X_i) \neq c(X_i)\}, & (\text{deterministic setting}); \\ &= \frac{1}{n} \sum_{i=1}^n \mathbb{1} \{g(X_i) \neq Y_i\}, & (\text{stochastic setting}). \end{aligned}$$

- **Remark** Not to be confused with $L_n(g) := L(g_n) = \mathcal{P}_{X,Y} \{g_n(X) \neq Y\}$, where the subscript n indicates the dependency of g on \mathcal{D}_n .
- **Remark (*Optimal Rule within A Subclass of Functions*)**
Given a subset of functions/concepts $\mathcal{H} \subset \mathcal{C}$, the *best possible error probability* by

$$L = \inf_{g \in \mathcal{H}} L(g). \Rightarrow g^* \in \operatorname{argmin}_{g \in \mathcal{H}} L(g)$$

Note that $L \geq L^*$. The optimal error rate L is a function of $\mathcal{P}_{X,Y}$ and \mathcal{H} .

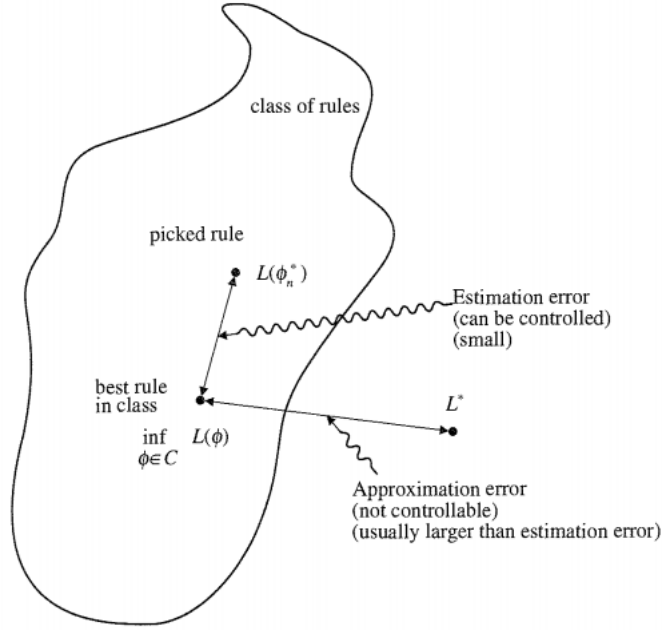


Figure 1: Estimation Error vs. Approximation Error [Devroye et al., 2013]

- **Remark (*Optimal Rule under Empirical Error Probability*)**

Given a subset of functions/concepts $\mathcal{H} \subset \mathcal{C}$, the **empirically optimal rule** g_n^* is given by

$$g_n^* := g_n^*(\cdot | \mathcal{D}_n) \in \arg \min_{g \in \mathcal{H}} \widehat{L}_n(g).$$

- **Remark (*Estimation Error vs. Approximation Error*)**

Their difference is the quantity that primarily interests us:

$$L(g_n^*) - L := L(g_n^*) - \inf_{g \in \mathcal{H}} L(g)$$

Note that both quantities are generalization error not training error. To compare with *Bayes error*, we have the following decomposition

$$L(g_n^*) - L^* = \left(L(g_n^*) - \inf_{g \in \mathcal{H}} L(g) \right) + \left(\inf_{g \in \mathcal{H}} L(g) - L^* \right).$$

1. The first difference term is called ***the estimation error***;
2. the second difference term is called ***the approximation error***. This latter term may be bounded in a ***distribution-free manner***, and a *rate of convergence results that only depends on the structure of \mathcal{H}* .

When the sub-class of functions \mathcal{H} is **large**, $L = \inf_{g \in \mathcal{H}} L(g)$ may be close to L^* , but the former error, *the estimation error*, is probably **large** as well. If \mathcal{H} is **too small**, there is no hope to make the approximation error small.

In empirical risk minimization, the subclass \mathcal{H} is **fixed**, and we have to live with the functions in \mathcal{H} . *The best we may then hope for is to minimize $L(g_n^*) - \inf_{g \in \mathcal{H}} L(g)$.*

- **Remark (*Overfitting*)**

If $\mathcal{H} = \mathcal{Y}^{\mathcal{X}}$ is the class of all (measurable) decision functions, then we can always find a classifier in \mathcal{H} with **zero empirical error**, but it may have **arbitrary values outside of the points** X_1, \dots, X_n . For example, an *empirically optimal classifier* is

$$g_n^*(x) = \begin{cases} Y_i & x = X_1, \dots, X_n \\ 0 & \text{otherwise} \end{cases}$$

This is clearly not what we are looking for. This phenomenon is called **overfitting**, as the overly large class \mathcal{H} *overfits* the data.

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